

Form PTO-1449 U.S. Department of Commerce Patent and Trademark Office				Atty. Docket No.: FMW-SS (CZ 51)		Serial No.: 10/010,135	
<div style="border: 1px solid black; border-radius: 50%; padding: 10px; display: inline-block; text-align: center;"> LIST OF PRIOR ART CITED BY APPLICANT (Use several sheets if necessary) FEB 14 2002 </div>				Applicant: Dr. Uwe W. Hamm		Group: 2877	
Filing Date: December 6, 2001							

U.S. PATENT DOCUMENTS							
EXAMINER Initial	Document Number	Date	Name	Class	Subclass	Filing date if appropriate	
HP	AA	4,614,427	September 30, 1986	Koizumi et al.	_____	_____	
HP	AB	5,024,968	June 18, 1991	Engelsberg	_____	_____	
	AC						
	AD						
	AE						
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	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS							
Document Number	Date	Country	Class	Subclass	Translation Yes No		
HP	AL	WO 87/02603	May 7, 1987	WIPO	_____	_____	
HP	AM	WO 00/31780	June 2, 2000	WIPO	_____	_____	
HP	AN	2000306807	November 2, 2000	JP Abstract	_____	_____	
HP	AO	09089650	April 4, 1997	JP Abstract	_____	_____	
HP	AP	2000323396	November 24, 2000	JP Abstract	_____	_____	

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)			
HP	AR	In Situ Reactive Cleaning of X-Ray Optics by Glow Discharge, Erik D. Johnson and Richard F. Garrett, Nuclear Instruments and Methods in Physics Research A266 (1988), pp 381-385, North-Holland Physics Publishing Division, Amsterdam	
	AS		
	AT		

EXAMINER		DATE CONSIDERED	2/5/04
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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U.S. PATENT DOCUMENTS							
Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing date if appropriate	
	AA						
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	AF		None				
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation Yes No	
JP	AL	11-329931	November 30, 1999	JP			
EP	AM	1 143 491	October 10, 2001	EP			
EP	AN	874 283	October 28, 1998	EP			
EP	AO	421 745	January 18, 1995	EP			
EP	AP	660 188	June 28, 1995	EP			

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)			
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